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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/709,361 04/29/2004		Eric A. Foreman	BUR920040075US1	3360
29625	7590 07/14/2005		EXAMINER	
MCGUIRE WOODS LLP 1750 TYSONS BLVD. SUITE 1800			LE, TOAN M	
			ART UNIT	PAPER NUMBER
MCLEAN, VA 22102-4215			2863	
			DATE MAILED: 07/14/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)			
	10/709,361	FOREMAN ET AL.			
Office Action Summary	Examiner	Art Unit			
	Toan M. Le	2863			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period was a reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	66(a). In no event, however, may a reply be time within the statutory minimum of thirty (30) days fill apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	ely filed will be considered timely. he mailing date of this communication. (35 U.S.C. § 133).			
Status					
 1) ⊠ Responsive to communication(s) filed on 29 Appears 2a) ☐ This action is FINAL. 2b) ☒ This 3) ☐ Since this application is in condition for alloward closed in accordance with the practice under Expensive to communication(s) filed on 29 Appears 	action is non-final. nce except for formal matters, pro				
Disposition of Claims	•				
4) ☐ Claim(s) 1-31 is/are pending in the application. 4a) Of the above claim(s) is/are withdray 5) ☐ Claim(s) 13-22 is/are allowed. 6) ☐ Claim(s) 1,2,9,10,12,23,24,26 and 28-31 is/are 7) ☐ Claim(s) 3-8,11,25 and 27 is/are objected to. 8) ☐ Claim(s) are subject to restriction and/o Application Papers 9) ☐ The specification is objected to by the Examine 10) ☐ The drawing(s) filed on 29 April 2004 is/are: a)	rejected. relection requirement.	ov the Examiner.			
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received.					
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 5/17/04. S. Patent and Trademark Office	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:				

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DETAILED ACTION

Claim Objections

Claim 30 is objected to because of the following informalities:

Claim 30, line 3, "13" should read -23-.

Appropriate correction is required.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-2, 9-10, 12, 23-24, 26, and 28-31 are rejected under 35 U.S.C. 102(b) as being "A General probabilistic Framework for Worst Case Timing Analysis" by Orshansky et al. (referred hereafter Orshansky et al.).

Referring to claims 1, 12, and 31, Orshansky et al. disclose a method and a computerreadable medium containing instructions thereon that, when executed, cause a computer analyzing timing in an integrated circuit (Abstract), comprising:

identifying at least one set of racing paths within the integrated circuit, the at least one set of racing paths including an early path and a late path (page 557, 2nd col., section 4.2: 1st paragraph);

identifying at least one delay characteristic of one or more elements in the early path and at least one delay characteristic of one or more elements in the late path (page 558, 1st col., lines ' 3-16);

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grouping ones of the one or more elements in the early path with ones of the one or more elements in the Tate path having similar delay characteristics (page 557, 2nd col., last paragraph; page 558, 1st col., 2nd paragraph; equations 3-5); and

deriving an adjusted timing slack for the at least one set of racing paths by at least partially canceling delay contributions from grouped elements having similar delay characteristics (page 558, section 5.1: 1st paragraph; page 559 to page 560, all section of 5.2; page 560, section 6: 1st paragraph; Table 2).

As to claim 2, Orshansky et al. disclose a method of analyzing timing in an integrated circuit (Abstract), wherein the similar delay characteristics comprise correlated delay functions (page 558, 1st col., lines 17-29; equations 3-5).

Referring to claim 9, Orshansky et al. disclose a method of analyzing timing in an integrated circuit (Abstract), wherein the similar delay characteristics comprise location-based delay characteristics (page 558, 2nd col., lines 13-16).

As to claim 10, Orshansky et al. disclose a method of analyzing timing in an integrated circuit (Abstract), wherein the grouped elements comprise one or more pairs of elements, one element of each of the one or more pairs from the early path and one element of each of the one or more pairs from the late path (Table 2).

Referring to claims 23 and 30, Orshansky et al. disclose a method and a computerreadable medium containing instructions thereon that, when executed, cause a computer analyzing timing in an integrated circuit (Abstract), comprising:

identifying a late path to a timing test and an early path to a timing test (page 57, 2nd col., section 4.2: 1st paragraph);

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determining by using location information at least one pair of one element of the late path and one element of the early path (page 558, 2nd col., lines 13-16);

computing by using the location information a variation in a difference in delays of the elements of the at least one pair (Table 2); and

deriving from the variation a slack for the late path to the timing test and the early path to the timing test (Table 3).

As to claim 24, Orshansky et al. disclose a method of analyzing timing in an integrated circuit (Abstract), wherein the at least one pair comprises several pairs (Table 2).

Referring to claim 26, Orshansky et al. disclose a method of integrated circuit (Abstract), wherein the location infor mation comprises physical location coordinates (Table 2).

As to claims 28-29, Orshansky et al. disclose a method of analyzing timing in an integrated circuit (Abstract), wherein the integrated circuit is an existing/newly integrated circuit (Table 2).

Claims 3-8, 11, 25, and 27 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The reason for allowance of the claims 3-5 is the inclusion of summing delay contributions of ungrouped elements in the early/late path, calculating a delay difference between the early path and late path by using the summed delay contributions of the ungrouped elements in the early/late paths, and subtracting the delay difference from the initial timing slack, wherein the summing comprises root sum squaring and root sum square difference.

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The reason for allowance of the claims 6-8 is the inclusion of calculating metal layer delays for the early and late paths, summing like metal layer delay contributions in the early/late paths, calculating a metal layer delay difference between the metal layer delay contributions for the early path and late path, and subtracting the metal layer delay difference from the initial timing slack, wherein the summing comprises root sum squaring and root sum square difference.

The reason for allowance of the claim 11 is the inclusion of computing a variation in a difference in delays of the one or more pairs of elements by using the location-based delay characteristics and subtracting the variation from an initial timing slack.

The reason for allowance of the claim 25 is the inclusion of adding the variation of unpaired elements to the slack.

The reason for allowance of the claim 27 is the inclusion of identifying one or more failing tests of the static timing analysis and using an early path/late path of one or more failing tests as the early path/late path of the timing tests.

Allowable Subject Matter

Claims 13-22 are allowed.

The reason for allowance of the claims 13-22 is the inclusion of sorting the delay contributions into groups with similar delay contributions including groups of correlated delay contributions and groups with dissimilar delay contributions, canceling the delay contributions of the groups with similar delay contributions, and comparing the delay contributions of the groups with dissimilar delay contributions with an initial timing slack calculated for the set of racing paths, wherein the delay contributions comprise cell-based/wire-dependent and cell-based and wire-dependent delay contributions of the existing/newly-designed integrated circuit including

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performing a static timing analysis to identify a failing test of the static timing analysis in order to use a set of racing paths of the failing test.

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

"Block-Based Static Timing Analysis with Uncertainty", Devgan et al., ICCAD 2003, Pages 607-614.

"Timing Analysis and Delay-Fault Test Generation Using Path-Recursive Functions", McGeer et al., 1991 IEEE, Pages 180-183.

"Slope Propagation in Static Timing Analysis", Blaauw et al., IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems, Vol. 21, No. 10, October 2002, Pages 1180-1195.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Toan M. Le whose telephone number is (571) 272-2276. The examiner can normally be reached on Monday through Friday from 9:00 A.M. to 5:30 P.M..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on (571) 272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR

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Toan Le

July 6, 2005

MICHAEL NGHIEM
PRIMARY EXAMINER